

N-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}$ (Ω)	I _D (A) ^a	Q _g (Typ.)			
30	0.017at V _{GS} = 10 V	10	7.2 nC			
	0.021 at V _{GS} = 4.5 V	8	7.2110			

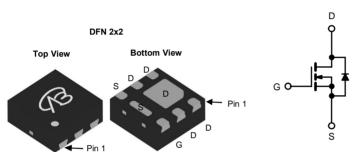
FEATURES

- · Halogen-free
- TrenchFET® Power MOSFET
- Optimized for High-Side Synchronous Rectifier Operation
- 100 % R_q Tested
- 100 % UIS Tested

RoHS

APPLICATIONS

- Notebook CPU Core
- High-Side Switch



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V _{DS}	30			
Gate-Source Voltage	V_{GS}	± 20	V		
	T _C = 25 °C		10		
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 70 °C	1 .	7		
Continuous Diam Current (1) = 150 °C)	T _A = 25 °C	I _D	9 ^{b, c}		
	T _A = 70 °C		6.3 ^{b, c}	۸ .	
Pulsed Drain Current		I _{DM}	30	Α	
Continuous Source-Drain Diode Current	T _C = 25 °C	l _a	3.7		
Continuous Source-Drain Diode Current	T _A = 25 °C	- I _S	2.0 ^{b, c}		
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	20	7	
Avalanche Energy	L = 0.1 IIII1	E _{AS}	21	mJ	
	T _C = 25 °C		4.1	W	
Maximum Power Dissipation	$T_C = 70 ^{\circ}C$	P _D	2.5		
Maximum Power Dissipation	T _A = 25 °C] 'D	2.2 ^{b, c}]	
	T _A = 70 °C		1.3 ^{b, c}		
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 150	°C		

THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA}	39	55	°C/W		
Maximum Junction-to-Foot (Drain)	Steady State	R_{thJF}	25	29	C/VV		

Notes:

- a. Base on T_C = 25 °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. Maximum under Steady State conditions is 85 °C/W.



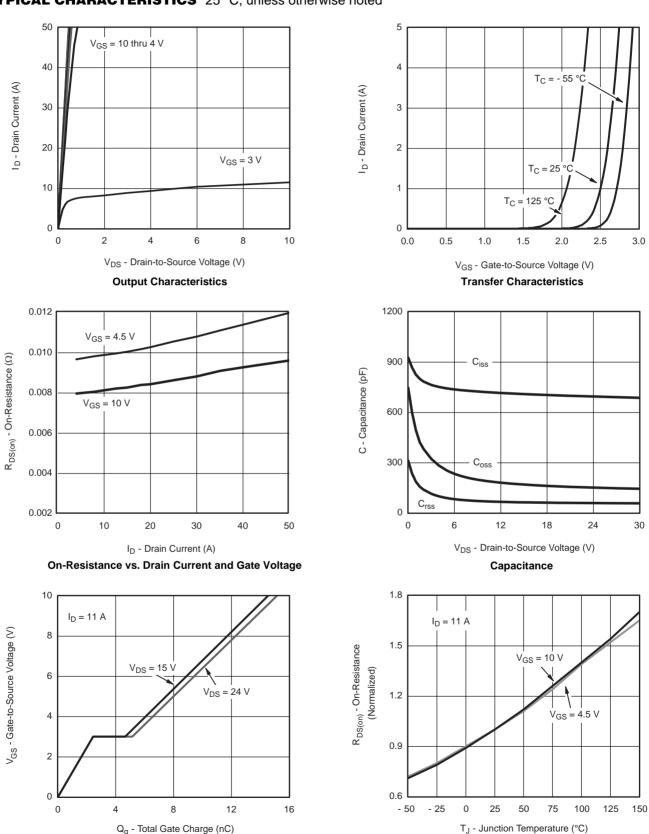
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static					1	
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30			V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	ID = 250 UA		26		>//96
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_{J}$			- 6		mV/°(
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		1.5		V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
Zana Oata Valla va Basia Oamaat		$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$			1	μA
Zero Gate Voltage Drain Current	IDSS	V _{DS} = 30 V, V _{GS} = 0 V, T _J = 55 °C			10	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	20			Α
		V _{GS} = 10 V, I _D = 10 A		0.017		Ω
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 4.5 V, I _D = 9 A		0.021		
Forward Transconductance ^a g_{fs} $V_{DS} = 15 \text{ V}, I_D = 10 \text{ A}$			50		S	
Dynamic ^b	<u> </u>			L		
Input Capacitance	C _{iss}			900		
Output Capacitance	C _{oss}	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		165		pF
Reverse Transfer Capacitance	C _{rss}			73		
· ·	Qg	V _{DS} = 15 V, V _{GS} = 10 V, I _D = 10 A		15	23	nC
Total Gate Charge				6.8	10.2	
Gate-Source Charge	Q _{gs}	$V_{DS} = 15 \text{ V}, V_{GS} = 5 \text{ V}, I_{D} = 10 \text{ A}$		2.5		
Gate-Drain Charge	Q_{gd}			2.3		
Gate Resistance	R_g	f = 1 MHz	0.36	1.8	3.6	Ω
Turn-On Delay Time	t _{d(on)}			16	23	ns
Rise Time	t _r	V_{DD} = 15 V, R_L = 1.4 Ω		12	16	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 9 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		16	22	
Fall Time	t _f			10	18	
Turn-On Delay Time	t _{d(on)}			8	16	
Rise Time	t _r	V_{DD} = 15 V, R_L = 1.4 Ω		10	20	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 9 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		16	22	
Fall Time	t _f			8	15	
Drain-Source Body Diode Characterist	ics					
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			10	Δ
Pulse Diode Forward Current ^a	I _{SM}				30	A
Body Diode Voltage	V_{SD}	I _S = 9 A		0.8	1.2	V
Body Diode Reverse Recovery Time	t _{rr}			15	30	ns
Body Diode Reverse Recovery Charge	I _F = 9 A dI/dt = 100 A/US I _J = 25 °			6	12	nC
Reverse Recovery Fall Time				8		
Reverse Recovery Rise Time	t _b			7		ns

Notes:

- a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



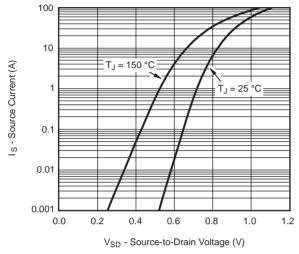


服务热线:400-655-8788

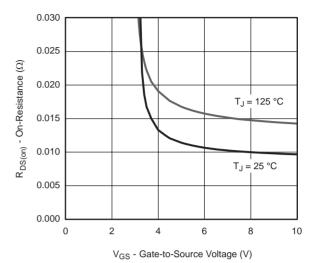
Gate Charge

On-Resistance vs. Junction Temperature

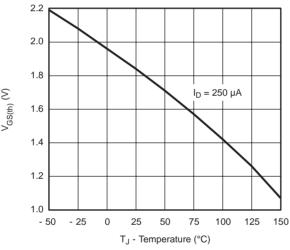




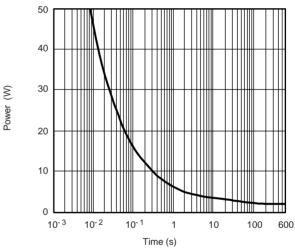




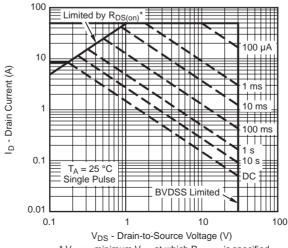
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



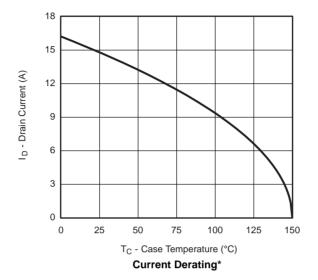
Single Pulse Power, Junction-to-Ambient

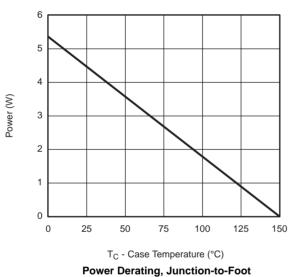


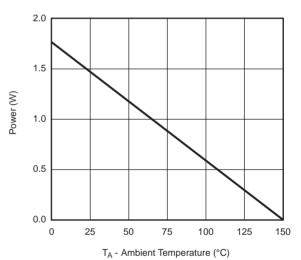
* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

Safe Operating Area, Junction-to-Ambient





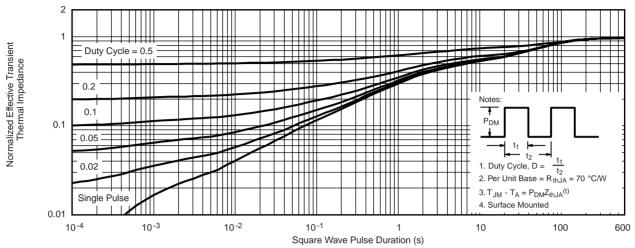




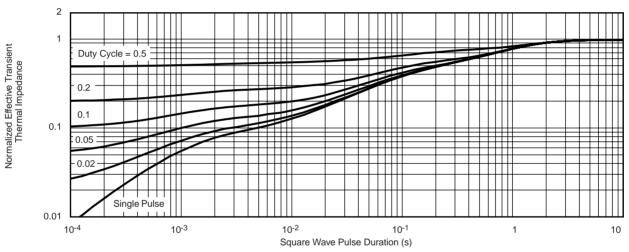
Power Derating, Junction-to-Ambient

^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





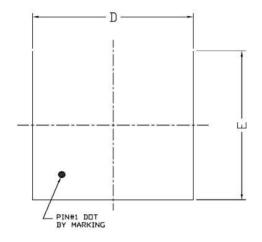
Normalized Thermal Transient Impedance, Junction-to-Ambient

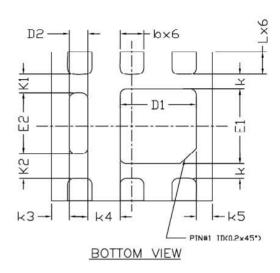


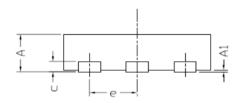
Normalized Thermal Transient Impedance, Junction-to-Foot



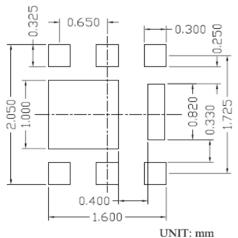
DFN2x2 _6L_EP1_S PACKAGE OUTLINE







RECOMMENDED LAND PATTERN



ma more	DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES			
SYMBOLS	MIN	NOM	MAX	MIN	NOM	MAX	
A	0.50	0.55	0.60	0.020	0.022	0.024	
A 1	0.00		0.05	0.000		0.002	
b	0. 25	0.30	0.35	0.010	0.012	0.014	
c	0. 152 REF				0.006 REF		
D	1.90	2.00	2.10	0.075	0.079	0.083	
D1	0.85	0.95	1.05	0.033	0.037	0.041	
D2	0.13	0.23	0.33	0.005	0.009	0.013	
E	1.90	2.00	2.10	0.075	0.079	0.083	
E1	0.90	1.00	1.10	0.035	0.039	0.043	
E2	0.72	0.82	0.92	0.028	0.032	0.036	
e	0.65 BSC			0. 026 BSC			
K	0. 20 BSC			0.008 BSC			
K1	0. 25 BSC			0.010 BSC			
K2	0.33 BSC			0. 013 BSC			
K3	0. 22 BSC			0.009 BSC			
K4	0. 40 BSC			0.016 BSC			
K5	0. 20 BSC			0.008 BSC			
L	0.25	0.30	0.35	0.010	0.012	0.014	

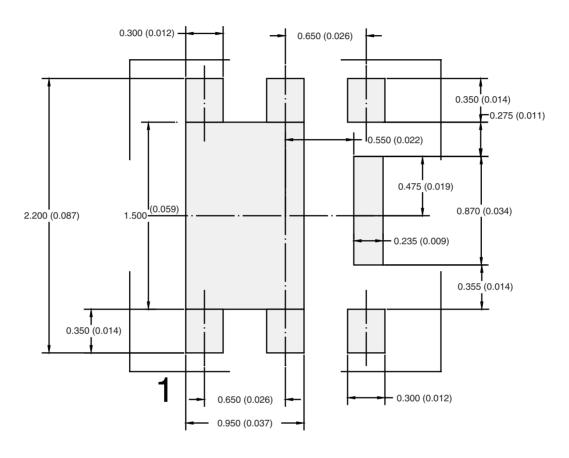
NOTE

1. CONTROLLING DIMENSION IS MILLIMETER.

CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.



RECOMMENDED PAD LAYOUT FOR DFN2X2



Dimensions in mm/(Inches)



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